

- The ShaH-6060 - industrial Shack-Hartman wavefront sensor is intended for a wide range of applications including fast and precise quality control of optical elements, airflow analysis, measurement of laser beam parameters, etc.

- A special high-precision algorithm for locating hartmann image spots centers provides very accurate measurements even in difficult viewing conditions.

- The SDK (C++) allows to operate all functions of the sensor and to achieve easy integration with user software.

TECHNICAL SPECIFICATIONS

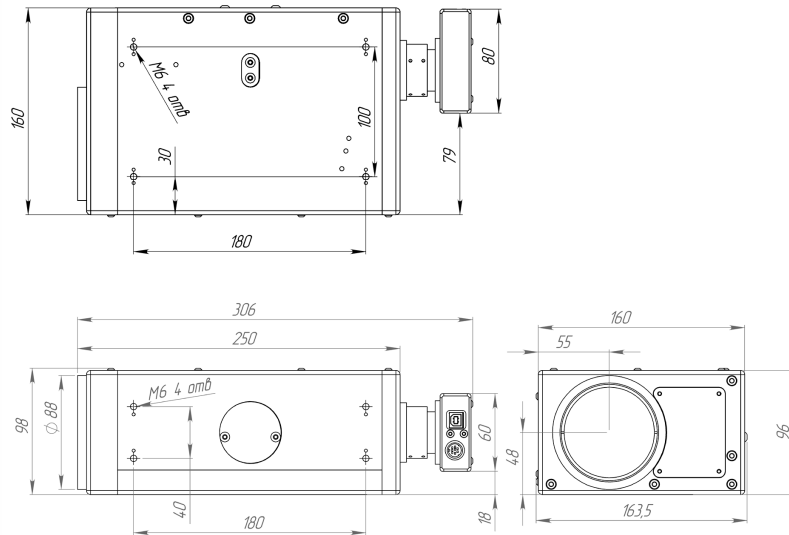
Aperture diameter	60 mm
Spatial resolution	1.5 mm
Number of points for analysis	1500
Maximum tilt normal/extended mode	±2.5/7.5 mrad
Minimum curvature	±12 m
Repeatability RMS	0.4 nm
Absolute accuracy RMS	$\lambda/100$ *
Relative accuracy RMS (at maximum angular source size <1 mrad)	$\lambda/1800$
Relative measurement accuracy P-V (within 90% of input aperture)	$\lambda/450$
Tilt measurement sensitivity	0.025 μ rad
Curvature measurement sensitivity	580 km
Acquisition frequency	60 Hz
Processing frequency	up to 60 Hz
Hartmann image acquisition	8/10 bit
Working wavelength	350-1100 nm
Calibrated waveband	200 nm
Maximal exposure (at wavelength 720 nm)	0.13 nJ/cm ²
Working temperature	from 0 to +40 °C
Weight	2.8 kg
Dimensions	300x160x100 mm

* Better accuracy available upon request



Interface/power supply	USB-2
Synchronization connector	Mini DIN
Operating system	Windows 2000/XP/Vista/7/8 (32/64-bit)
Output data	<ul style="list-style-type: none"> • Sequence of raw hartmann images • Spot shift map • Wavefront aberration map (3D plot, 2D projection, synthesized interferogram, up to 55 Zernike polynomials) • Defocus/Curvature/Astigmatism • PSF (point spread function) • MTF (modulation transfer function) • Strehl ratio • M2 factor • Gauss-Hermite modes • Turbulence parameters C_n^2, R_0 and other

DIMENSIONS



SPECTRAL RESPONSIVITY

